onsemi

IGBT - Power, Single N-Channel, Field Stop IV (FS4), High Speed, D2PAK-7L-LV

650 V, 1.55 V, 70 A

AFGBG70T65SQ

Using the novel field stop 4th generation IGBT technology, AFGBG70T65SQ offers the optimum performance with both low conduction and switching losses for high efficiency operations in various applications.

Features

- Maximum Junction Temperature: $T_J = 175^{\circ}C$
- Positive Temperature Coefficient for Easy Parallel Operation
- High Current Capability
- Low Saturation Voltage: $V_{CE(Sat)} = 1.55 \text{ V} (Typ.) @ I_C = 70 \text{ A}$
- 100% of the Parts are Tested for ILM (Note 1)
- Fast Switching
- Tight Parameter Distribution
- AECQ101 Qualified and PPAP Capable

Applications

- Automotive HEVEV Onboard Chargers
- Automotive HEVEV DCDC Converters
- Totem Pole Bridgeless PFC

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

Parameter		Symbol	Value	Unit
Collector-to-Emitter Voltage		V _{CES}	650	V
Gate-to-Emitter Voltage		V _{GES}	±20	V
Transient Gate-to-Emitter Voltage	V _{GES}	±30	V	
Collector Current	$T_{C} = 25^{\circ}C$	Ι _C	75	А
	$T_{\rm C} = 100^{\circ}{\rm C}$		70	
Power Dissipation $T_{C} = 25^{\circ}C$		PD	714	W
	T _C = 100°C		357	
Pulsed Collector Current (Note 2)	T _C = 25°C, t _p = 10 μs	I _{CM}	280	A
Operating Junction and Storage Temperature Range		T _J , T _{stg}	–55 to +175	°C
Lead Temperature for Soldering Purposes		TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. V_{CC} = 400 V, V_{GE} = 15 V, I_C = 315 A, Inductive Load, 100% of the Parts are Tested

2. Single pulse, limited by max junction temperature

BV _{CES}	V _{CE(SAT)}	I _C
650 V	1.55 V	70 A





AFGB7065SQ = Specific Device Code

- A = Assembly Location
- Y = Year
- WW = Work Week
- ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
AFGBG70T65SQ	D ² PAK7 (Pb–Free)	800 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Parameter	Symbol	Max	Unit
Thermal Resistance, Junction-to-Case for IGBT	$R_{ hetaJC}$	0.29	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{ hetaJA}$	40	

ELECTRICAL CHARACTERISTICS OF IGBT (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Collector-to-Emitter Breakdown Voltage	BV _{CES}	V_{GE} = 0 V, I_{C} = 1 mA	650			V
Collector-to-Emitter Breakdown Voltage Temperature Coefficient	$\Delta BV_{CES}/\Delta T_{J}$	V_{GE} = 0 V, I _C = 5 mA		0.6		mV/°C
Zero Gate Voltage Collector Current	I _{CES}	V_{GE} = 0 V, V_{CE} = V_{CES}			250	μA
Gate-to-Emitter Leakage Current	I _{GES}	V_{GE} = 20 V, V_{CE} = 0 V			±400	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	V _{GE(TH)}	$V_{GE} = V_{CE}$, $I_C = 70 \text{ mA}$	3.4	4.68	6.4	V
Collector-to-Emitter Saturation Voltage	V _{CE(SAT)}	V_{GE} = 15 V, I _C = 70 A, T _J = 25°C		1.55	2.10	
		V _{GE} = 15 V, I _C = 70 A, T _J = 175°C		1.93		
DYNAMIC CHARACTERISTICS						
Input Capacitance	C _{IES}			4310		pF
Output Capacitance	C _{OES}	V _{GE} = 0 V, V _{CE} = 30 V, f = 1 MHz		56.9		
Reverse Transfer Capacitance	C _{RES}			14.5		
Total Gate Charge	Q _G			140.6		nC
Gate-to-Emitter Charge	Q _{GE}	V_{CE} = 400 V, V_{GE} = 15 V, I_{C} = 70 A		27.8		
Gate-to-Collector Charge	Q _{GC}			36.5		
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t _{d(on)}			16.4		ns
Turn-Off Delay Time	t _{d(off)}			118.7		
Rise Time	t _r			13.44		
Fall Time	t _f	$V_{CE} = 400 \text{ V}, V_{GE} = 0/15 \text{ V},$ $I_{C} = 35 \text{ A}, B_{C} = 4.7 \Omega, T_{L} = 25^{\circ}\text{C}$		10.08		
Turn-On Switching Loss	E _{on}			0.25		mJ
Turn-Off Switching Loss	E _{off}			0.19		
Total Switching Loss	E _{ts}			0.44		
Turn-On Delay Time	t _{d(on)}			18.4		ns
Turn-Off Delay Time	t _{d(off)}			114.4		
Rise Time	t _r			25.6		
Fall Time	t _f	V _{CE} = 400 V, V _{GE} = 0/15 V, Io = 70 A Bo = 4 7 Q T ₁ = 25°C		20.0		
Turn-On Switching Loss	E _{on}	–		0.6		mJ
Turn-Off Switching Loss	E _{off}			0.7		1
Total Switching Loss	E _{ts}			1.2		

ELECTRICAL CHARACTERISTICS OF IGBT (T_J = 25°C unless otherwise noted) (continued)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t _{d(on)}			12.8		ns
Turn-Off Delay Time	t _{d(off)}			147.2		
Rise Time	t _r			16.0		
Fall Time	t _f	V _{CE} = 400 V, V _{GE} = 0/15 V, I _C = 35 A. R _G = 4.7 Ω. T ₄ = 175°C		7.2		
Turn-On Switching Loss	E _{on}			0.4		mJ
Turn–Off Switching Loss	E _{off}			0.3		
Total Switching Loss	E _{ts}			0.7		
Turn-On Delay Time	t _{d(on)}			18.4		ns
Turn-Off Delay Time	t _{d(off)}			134.4		
Rise Time	t _r	V _{CE} = 400 V, V _{GE} = 0/15 V, I _C = 70 A, R _C = 4.7 Ω, T ₁ = 175°C		28.0		
Fall Time	t _f			18.2		
Turn-On Switching Loss	E _{on}			0.7		mJ
Turn–Off Switching Loss	E _{off}			0.8		
Total Switching Loss	E _{ts}			1.6		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS (CONTINUED)



TYPICAL CHARACTERISTICS (CONTINUED)



Figure 17. Transient Thermal Impedance of IGBT

PACKAGE DIMENSIONS





LAND PATTERN RECOMMENDATION

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NOTES:

- A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.
- OUT OF JEDEC STANDARD VALUE.
 D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009.
 E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.
 F. LAND PATTERN RECOMMENDATION PER IPC. TO127P1524X465-8N.

	MILLIMETERS			
DIN	MIN	NOM	MAX	
Α	4.30	4.50	4.70	
A1	0.00	0.10	0.20	
b2	0.60	0.70	0.80	
b	0.50	0.60	0.70	
с	0.40	0.50	0.60	
c2	1.20	1.30	1.40	
D	9.00	9.20	9.40	
D1	7.30	7.80	8.20	
E	9.70	9.90	10.20	
E1	7.15	8.05	8.55	
е	~	1.27	~	
Н	15.10	15.40	15.70	
L	2.44	2.64	2.84	
L1	1.00	1.20	1.40	
L3	~	0.25	~	
aaa	~	~	0.25	



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